# **Power MOSFET**

## 30 V, 54 A, Single N-Channel, DPAK/IPAK

## Features

- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- Low R<sub>G</sub>
- These are Pb–Free Devices

## Applications

- CPU Power Delivery
- DC–DC Converters

#### MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise noted)

Param	Symbol	Value	Unit		
Drain-to-Source Voltag	V <sub>DSS</sub>	30	V		
Gate-to-Source Voltage	e		V <sub>GS</sub>	±20	V
Continuous Drain		$T_A = 25^{\circ}C$	I <sub>D</sub>	10.8	А
Current (R <sub>0JA</sub> ) (Note 1)		$T_A = 85^{\circ}C$		8.4	
Power Dissipation $(R_{\theta JA})$ (Note 1)		$T_A = 25^{\circ}C$	P <sub>D</sub>	2.0	W
Continuous Drain		$T_A = 25^{\circ}C$	I <sub>D</sub>	8.6	А
Current ( $R_{\theta JA}$ ) (Note 2)	Steady	$T_A = 85^{\circ}C$		6.7	
Power Dissipation $(R_{\theta JA})$ (Note 2)	State	$T_A = 25^{\circ}C$	P <sub>D</sub>	1.28	W
Continuous Drain		$T_C = 25^{\circ}C$	Ι <sub>D</sub>	54	А
Current (R <sub>θJC</sub> ) (Note 1)		$T_C = 85^{\circ}C$		42	
Power Dissipation $(R_{\theta JC})$ (Note 1)		$T_C = 25^{\circ}C$	P <sub>D</sub>	50	W
Pulsed Drain Current	t <sub>p</sub> =10μs	T <sub>A</sub> = 25°C	I <sub>DM</sub>	120	А
Current Limited by Packa	age	$T_A = 25^{\circ}C$	I <sub>DmaxPkg</sub>	45	А
Operating Junction and	Storage Te	mperature	T <sub>J</sub> , T <sub>stg</sub>	-55 to 175	°C
Source Current (Body Di	ode)		ا <sub>S</sub>	41	А
Drain to Source dV/dt	dV/dt	6.0	V/ns		
Single Pulse Drain-to-Source Avalanche Energy (V <sub>DD</sub> = 24 V, V <sub>GS</sub> = 10 V, L = 0.3 mH, I <sub>L(pk)</sub> = 21 A, R <sub>G</sub> = 25 $\Omega$ )			E <sub>AS</sub>	66	mJ
Lead Temperature for So (1/8" from case for 10 s)	Idering Pu	poses	ΤL	260	°C

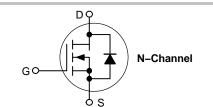
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

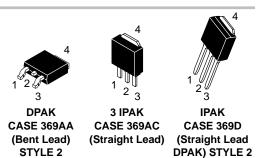


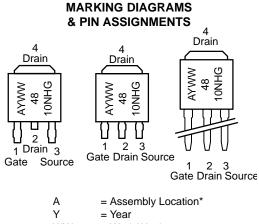
## **ON Semiconductor®**

#### http://onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(on)</sub> MAX	I <sub>D</sub> MAX
30 V	10 mΩ @ 10 V	54 A
30 V	16.7 mΩ @ 4.5 V	0+ A







WW = Work Week

4810NH = Device Code G

= Pb-Free Package

\* The Assembly Location code (A) is front side optional. In cases where the Assembly Location is stamped in the package, the front side assembly code may be blank.

#### **ORDERING INFORMATION**

See detailed ordering and shipping information on page 6 of this data sheet.

## THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{ extsf{ heta}JC}$	3.0	°C/W
Junction-to-TAB (Drain)	$R_{\theta JC-TAB}$	3.5	
Junction-to-Ambient - Steady State (Note 1)	$R_{\thetaJA}$	75	
Junction-to-Ambient - Steady State (Note 2)	$R_{ hetaJA}$	117	

Surface-mounted on FR4 board using 1 in sq pad size, 1 oz Cu.
 Surface-mounted on FR4 board using the minimum recommended pad size.

ELECTRICAL CHARACTERISTICS (T<sub>J</sub> = 25°C unless otherwise noted)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS}$ = 0 V, $I_D$ = 250 $\mu$ A		30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>				27		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V,	$T_J = 25^{\circ}C$			1.0	μΑ
		V <sub>DS</sub> = 24 V	T <sub>J</sub> = 125°C			10	
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{DS} = 0 V, V_0$	$_{GS} = \pm 20 \text{ V}$			±100	nA

**ON CHARACTERISTICS** (Note 3)

Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS}=V_{DS},I_{D}=250\;\mu A$		1.5		2.5	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				5.2		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	$V_{GS} = 10$ to	I <sub>D</sub> = 30 A		8.0	10	mΩ
		11.5 V	I <sub>D</sub> = 15 A		7.8		
		V <sub>GS</sub> = 4.5 V	I <sub>D</sub> = 30 A		14.1	16.7	
			I <sub>D</sub> = 15 A		13.2		
Forward Transconductance	gFS	V <sub>DS</sub> = 15 V, I <sub>D</sub> = 10 A			9.0		S

## CHARGES AND CAPACITANCES

Input Capacitance	C <sub>iss</sub>		1225		pF
Output Capacitance	C <sub>oss</sub>	V <sub>GS</sub> = 0 V, f = 1.0 MHz, V <sub>DS</sub> = 12 V	280		
Reverse Transfer Capacitance	C <sub>rss</sub>	103 12 1	145		
Total Gate Charge	Q <sub>G(TOT)</sub>		8.9	12	nC
Threshold Gate Charge	Q <sub>G(TH)</sub>	$V_{GS}$ = 4.5 V, $V_{DS}$ = 15 V,	2.5		
Gate-to-Source Charge	Q <sub>GS</sub>	I <sub>D</sub> = 30 A	3.6		
Gate-to-Drain Charge	Q <sub>GD</sub>		3.9		
Total Gate Charge	Q <sub>G(TOT)</sub>	$V_{GS}$ = 11.5 V, $V_{DS}$ = 15 V, $I_{D}$ = 30 A	22.5		nC

#### SWITCHING CHARACTERISTICS (Note 4)

Turn-On Delay Time	t <sub>d(on)</sub>		10.6	ns
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> = 15 V,	19.2	
Turn–Off Delay Time	t <sub>d(off)</sub>	$I_D = 15 \text{ A}, \text{ R}_G = 3.0 \Omega$	11.7	
Fall Time	t <sub>f</sub>	F	3.6	
Turn–On Delay Time	t <sub>d(on)</sub>		6.2	ns
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = 11.5 V, V <sub>DS</sub> = 15 V,	18	
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D = 15 \text{ A}, \text{ R}_G = 3.0 \Omega$	18.5	
Fall Time	t <sub>f</sub>		2.2	

## **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise noted) (continued)

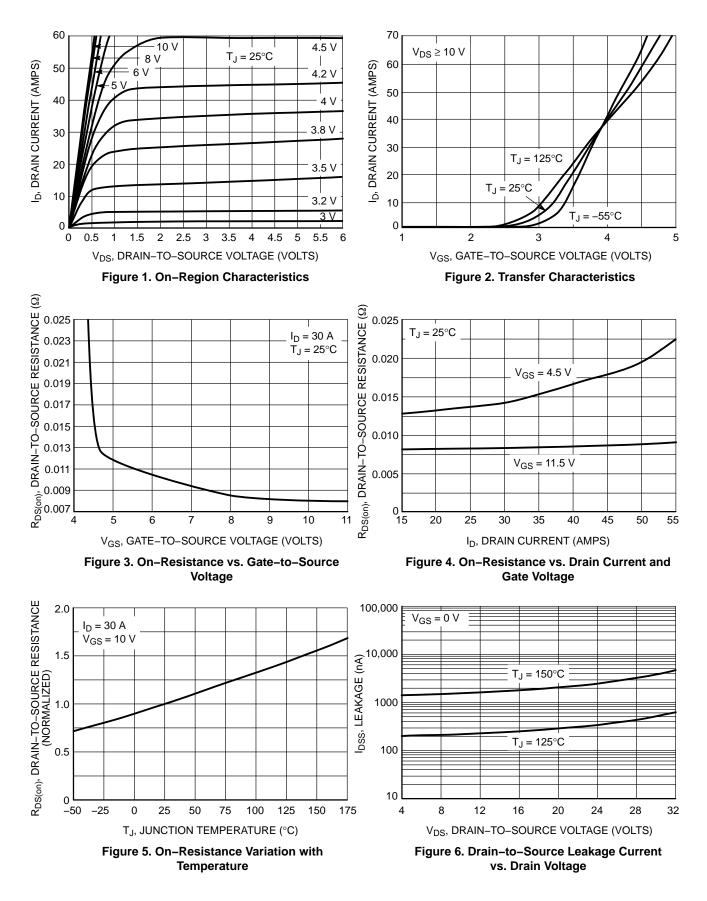
Parameter	Symbol	Test Co	Test Condition		Тур	Мах	Unit
DRAIN-SOURCE DIODE CHARACTERISTICS							
Forward Diode Voltage	V <sub>SD</sub>	V <sub>GS</sub> = 0 V,	$T_J = 25^{\circ}C$		0.88	1.2	V
		I <sub>S</sub> = 30 A	T <sub>J</sub> = 125°C		0.79		
Reverse Recovery Time	t <sub>RR</sub>				13.4		ns
Charge Time	ta	V <sub>GS</sub> = 0 V, dls/	dt = 100 A/μs,		9.1		
Discharge Time	tb	I <sub>S</sub> = 3	30 A		4.3		
Reverse Recovery Time	Q <sub>RR</sub>				6.7		nC
PACKAGE PARASITIC VALUES							
Source Inductance	L <sub>S</sub>				2.49		nH
Drain Inductance, DPAK	L <sub>D</sub>	]			0.0164		

Brain inductance, Bry it	=0		0.0101		
Drain Inductance, IPAK	LD	$T_A = 25^{\circ}C$	1.88		
Gate Inductance	L <sub>G</sub>		3.46		
Gate Resistance	R <sub>G</sub>		0.75	Ω	

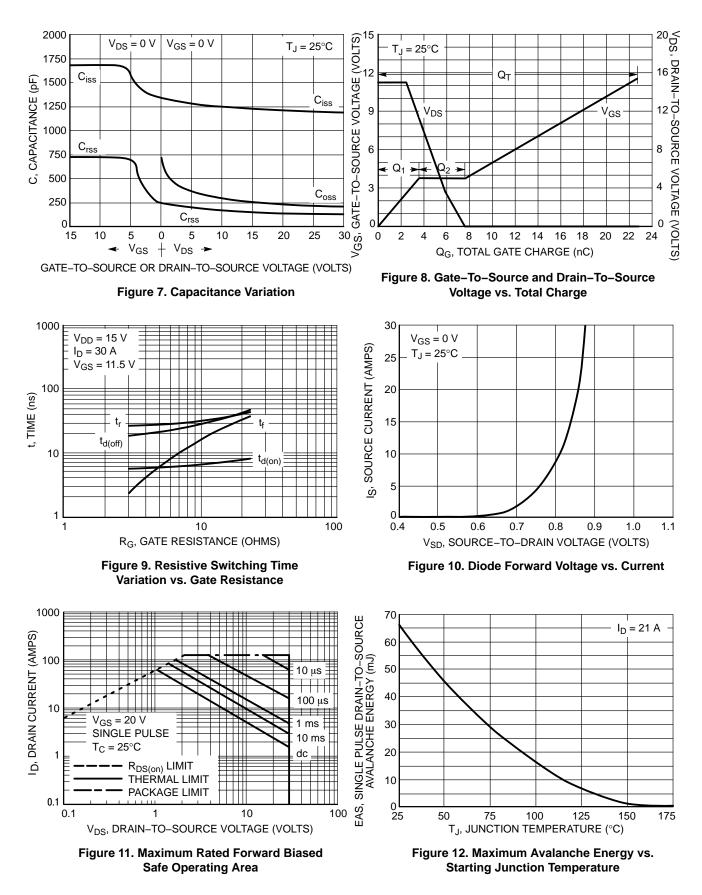
Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 3. Pulse Test: Pulse Width  $\leq$  300 µs, Duty Cycle  $\leq$  2%.

4. Switching characteristics are independent of operating junction temperatures.

## **TYPICAL PERFORMANCE CURVES**



## **TYPICAL PERFORMANCE CURVES**



## **TYPICAL PERFORMANCE CURVES**

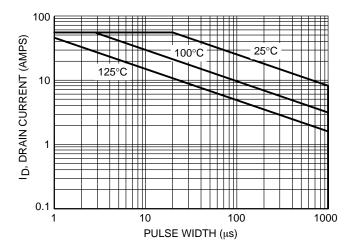
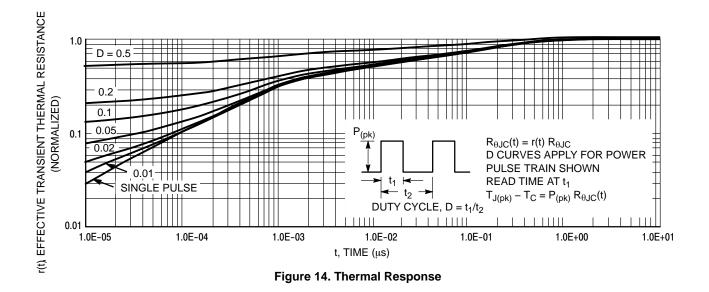


Figure 13. Avalanche Characteristics



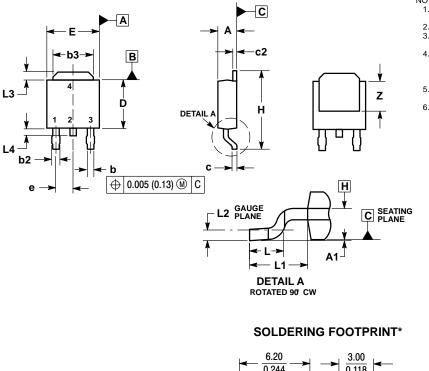
#### **ORDERING INFORMATION**

Order Number	Package	Shipping <sup>†</sup>
NTD4810NHT4G	DPAK (Pb–Free)	2500 Tape & Reel
NTD4810NH-1G	IPAK (Pb–Free)	75 Units/Rail
NTD4810NH-35G	IPAK Trimmed Lead $(3.5 \pm 0.15 \text{ mm})$ (Pb–Free)	75 Units/Rail

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

#### PACKAGE DIMENSIONS

**DPAK (SINGLE GUAGE)** CASE 369AA **ISSUE B** 



0.244 0.118 2.58 -0.102 . 5.80 1.60 6.17 0.228 0.243 0.063 ١  $\left(\frac{mm}{inches}\right)$ SCALE 3:1

NOTES:

- NOTES:
  1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
  2. CONTROLLING DIMENSION: INCHES.
  3. THERMAL PAD CONTOUR OPTIONAL WITHIN DI-MENSIONS b3, L3 and Z.
  4. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.006 INCHES PER SIDE.
  5. DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
  6. DATUMS A AND B ARE DETERMINED AT DATUM
- 6. DATUMS A AND B ARE DETERMINED AT DATUM PLANE H.

	INC	HES	MILLIMETERS		
DIM	MIN	MAX	MIN	MAX	
Α	0.086	0.094	2.18	2.38	
A1	0.000	0.005	0.00	0.13	
b	0.025	0.035	0.63	0.89	
b2	0.030	0.045	0.76	1.14	
b3	0.180	0.215	4.57	5.46	
С	0.018	0.024	0.46	0.61	
c2	0.018	0.024	0.46	0.61	
D	0.235	0.245	5.97	6.22	
Е	0.250	0.265	6.35	6.73	
e	0.090	BSC	2.29	BSC	
Н	0.370	0.410	9.40	10.41	
Г	0.055	0.070	1.40	1.78	
L1	0.108	REF	2.74	REF	
L2	0.020	BSC	0.51	BSC	
L3	0.035	0.050	0.89	1.27	
L4		0.040		1.01	
Ζ	0.155		3.93		

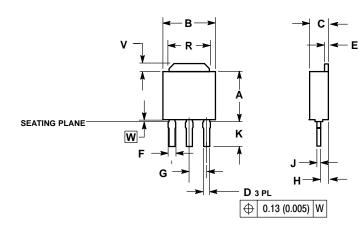
STYLE 2: PIN 1. GATE 2. DRAIN 3. SOURCE 4. DRAIN

\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

#### PACKAGE DIMENSIONS

## **3 IPAK, STRAIGHT LEAD**

CASE 369AC ISSUE O



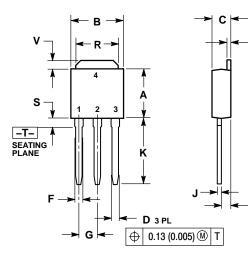
NOTES:

- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
  CONTROLLING DIMENSION: INCH.
  SEATING PLANE IS ON TOP OF
- DAMBAR POSITION. DIMENSION A DOES NOT INCLUDE 4
- DAMBAR POSITION OR MOLD GATE.

	INC	HES	MILLIM	ETERS
DIM	MIN	MAX	MIN	MAX
Α	0.235	0.245	5.97	6.22
В	0.250	0.265	6.35	6.73
С	0.086	0.094	2.19	2.38
D	0.027	0.035	0.69	0.88
Е	0.018	0.023	0.46	0.58
F	0.037	0.043	0.94	1.09
G	0.090	BSC	2.29	BSC
Н	0.034	0.040	0.87	1.01
J	0.018	0.023	0.46	0.58
κ	0.134	0.142	3.40	3.60
R	0.180	0.215	4.57	5.46
V	0.035	0.050	0.89	1.27
W	0.000	0.010	0.000	0.25

**IPAK** CASE 369D ISSUE C

Ε



Ζ

NOTES 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. 2. CONTROLLING DIMENSION: INCH.

	INCHES		MILLIMETERS	
DIM	MIN	MAX	MIN	MAX
Α	0.235	0.245	5.97	6.35
В	0.250	0.265	6.35	6.73
С	0.086	0.094	2.19	2.38
D	0.027	0.035	0.69	0.88
Е	0.018	0.023	0.46	0.58
F	0.037	0.045	0.94	1.14
G	0.090 BSC		2.29 BSC	
Н	0.034	0.040	0.87	1.01
J	0.018	0.023	0.46	0.58
κ	0.350	0.380	8.89	9.65
R	0.180	0.215	4.45	5.45
S	0.025	0.040	0.63	1.01
۷	0.035	0.050	0.89	1.27
Ζ	0.155		3.93	

STYLE 2: PIN 1. GATE 2. DRAIN

3. SOURCE 4 DRAIN

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